

EXPEDITED PROCEDURE – EXAMINING GROUP 2117

S/N 10/612,293

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Daniel A. Day	Examiner:	Phung M. Chung
Serial No.:	10/612,293	Group Art Unit:	2117
Filed:	June 30, 2003	Docket No.:	884.879US1
Title:	Selective Control of Test-Access Ports in Integrated Circuits		
Customer Number:	21186		

AMENDMENT & RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Final Office Action mailed May 1, 2007, please amend the application as follows:

ok to enter
qmc
7/16/07

✓